



AEC-Q 200 Qualified, High Reliability Crystal

Miniature Quartz Crystal Ceramic SMD

XRQ



Ceramic SMD

Product Features

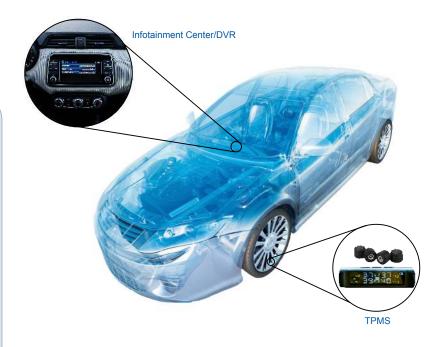
- Rugged AT-cut crystal construction
- Support high temperature: -40°C to 125°C
- Mechanical shock up to 8000G
- Wide frequency range: 12~66MHz
- Support 1500G centrifugal force
- JIS-C0044 Drop Test compliant
- AEC-Q 200 compliant
- -Grade 3, Grade 2, Grade 1
- Various packages:
- 2.0 x 1.6 mm
- 2.5 x 2.0 mm
- 3.2 x 2.5 mm
- Available on tape & reel; 8mm tape, 3000 units per reel
- Pb-free and RoHS/Green compliant

Product Description

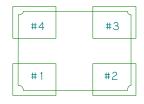
The 4-pad XRQ Series seam seal devices are housed in standard 3.2 x 2.5mm, 2.5 x 2.0mm and 2.0 x 1.6mm ceramic packages. The devices are ideal for surface mounting in densely populated or small form-factor PCB applications. The XRQ series is designed to be highly reliable in automotive applications, and perform accurately in harsh conditions. The crystals meet the requirements of AEC-Q 200 Grade 3, Grade 2 and Grade 1. The series supports operating temperature range of -40° C up to $+125^{\circ}$ C.

Applications

- Tire-Pressure Monitoring System (TPMS)
- Infotainment & Telematics
- Advanced Driver Assisted System (ADAS)



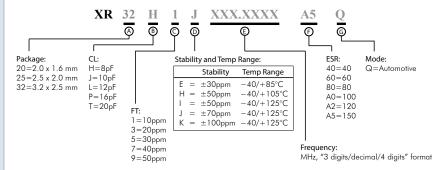
Top View Pin Location



Pin Functions:

Pin	Function
1	Xtal
2	GND
3	Xtal
4	GND

Part Ordering Information:



Please contact us for custom requirements for your specific application needs.





AEC-Q 200 Qualified High Reliability Crystal

2.0 x 1.6 Package

Frequency Range:*

• 24.0000 MHz to 66.0000 MHz (Fundamental)

Characteristics at 25°C ±3°C:

- Frequency Calibration Tolerance: ±10ppm to ±50ppm*
- Load Capacitance: 7 to 32pF or Series Resonance*
- Effective Series Resistance (ESR):*

24.0000 MHz to 29.9999 MHz : 120Ω max 30.0000 MHz to 59.9999 MHz : 80Ω max 60.0000 MHz to 66.0000MHz : 60Ω max

- Drive Level: $10\mu W$ typ. $(100\mu W \text{ max})$
- Shunt Capacitance: 3pF Max

2.5 x 2.0 Package

Frequency Range:*

• 16.0000 MHz to 66.0000 MHz (Fundamental)

Characteristics at 25°C ±3°C:

- Frequency Calibration Tolerance: ±10ppm to ±50ppm*
- Load Capacitance: 7 to 32pF or Series Resonance*
- Effective Series Resistance (ESR):*

16.0000 MHz to 19.9999 MHz : 150Ω max 20.0000 MHz to 31.9999 MHz : 80Ω max 32.0000 MHz to 66.0000 MHz : 60Ω max

- Drive Level: $10\mu W$ typ. $(100\mu W \text{ max})$
- Shunt Capacitance: 3pF Max

3.2 x 2.5 Package

Frequency Range:*

• 12.0000 MHz to 66.0000 MHz (Fundamental)

Characteristics at 25°C ±3°C:

- Frequency Calibration Tolerance: ±10ppm to ±50ppm*
- Load Capacitance: 7 to 32pF or Series Resonance*
- Effective Series Resistance (ESR):*

12.0000 MHz to 19.9999 MHz : 100Ω max 20.0000 MHz to 31.9999 MHz : 60Ω max 32.0000 MHz to 66.0000 MHz : 40Ω max

- Drive Level: $10\mu W$ typ. $(100\mu W max)$
- Shunt Capacitance: 3pF Max

2.0 x 1.6, 2.5 x 2.0 and 3.2 x 2.5 Packages

Temperature Range: *

- Operating: -40 to +85°C or -40 to +105°C or -40 to +125°C
- Storage: -55 to +125°C

Temperature Stability:*

• ±30ppm to ±100ppm (-40 to 125°C)

Aging at 25°C, First Year:

• ±3ppm Max

Reflow Temperature:

• 260°C Max, 10 seconds Max

Centrifugal Force:

• SAE J2657

Mechanical:

- Shock: MIL-STD-202 Method 213
- Solderability: J-STD-002
- Vibration: MIL-STD-202 Method 204
- Resistance to Soldering Heat: MIL-STD-202 Method 210
- Drop Test: JIS-C0044

Environmental:

- Gross Test Leak: JESD22-A11
- Fine Test Leak: MIL-STD-883E Method 1014
- High Temp & High Humidity: MIL-STD-202, Method 103
- Insulation Resistance: 500 MΩ min (100 VDC)
- High Temperature Exposure : MIL-STD-202, Method 108
- High Temperature Operation Life: MIL-STD-202 Method 108
- Temperature Cycling: JESD22-A104
- Board Flex: AEC Q200-005

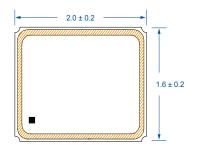
*Note: See Part Ordering Information

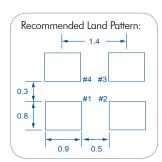


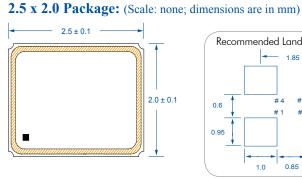
A product Line of Diodes Incorporated PERICOM*

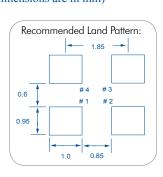
AEC-Q 200 Qualified High Reliability Crystal

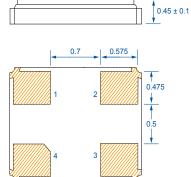
2.0 x 1.6 Package: (Scale: none; dimensions are in mm)

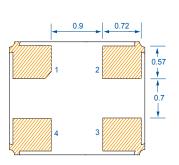




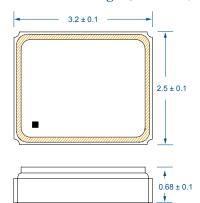


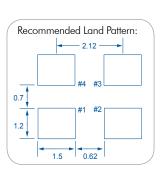


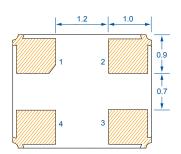




3.2 x 2.5 Package: (Scale: none; dimensions are in mm)











AEC-Q 200 Qualified High Reliability Crystal

IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel.

Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
 - 1. are intended to implant into the body, or
- 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2016, Diodes Incorporated www.diodes.com

© Diodes Incorporated • US: +1-408-232-9100 TW: +886-3-4518888 • www.diodes.com